

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination JAEGER ET AL.	
		Examiner Hector M Reyes	Art Unit 1625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kumar et al, Journal of Chromatography, Vol. 678 (1994) pp. 259-263
	V	Tabuchi et al, Tetrahedron Letters, vol. 34(14) pp. 2327-2230.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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